U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,593,925 B1	07-2003	Hakura et al.	345/426
	B	US-6,341,878 B1	01-2002	Chiang, Gilbert W. J.	362/293
	C	US-5,793,879	08-1998	Benn et al.	382/110
	D	US-5,631,976	05-1997	Bolle et al.	382/174
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Debevec al, "Acquiring the Reflectance Field of Human Face," ACM Proceedings of the 27th Annual Conference on Computer Graphics and Interactive Techniques, pp. 145-156 (July 2000)
	V	Backman et al, "Polarized Light Scattering Spectroscopy for Quantitative Measurement of Epithelial Cellular Structures In Situ," IEEE Journal on Selected Topics in Quantum Electronics, Vol. 5 No. 4, pp. 1019-1026 (July 1999)
	W	Kriegman et al, "Shape and Enlightenment: Reconstruction and Recognition Under Variable Illumination," 1999 International Symposium on Robotics Research (October 1999)(paper available at: ftp://cvc.yale.edu/Renderings/Papers/rc3_ISRR99.ps)
	X	Yuille et al, "Shape and Albedo from Multiple Images Using Integrability," 1997 IEEE Computer Society Conference on Computer Vision and Pattern Recognition, pp.158-164 (June 1997)

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.